Se	arch	Notes	

	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/816,878	ISHIHARA, HIROSHI	
	Examiner	Art Unit	
•	Quang N. Vo	2625	

SEARCHED			
Class	Subclass	Date	Examiner
358	2.1	6/20/2007	QV
358	518	6/20/2007	QV
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH		) ·
	DATE	EXMR
US Pat, US PG Pub, USOCR, EPO, JPO, DERWENT, IBM	6/20/2007	QV
Inventor Name Search, see attachment	6/20/2007	QV
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